

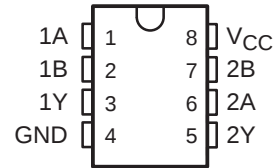
SN75471 THRU SN75473 DUAL PERIPHERAL DRIVERS

SLRS024 – DECEMBER 1976 – REVISED MAY 1990

PERIPHERAL DRIVERS FOR HIGH-VOLTAGE HIGH-CURRENT DRIVER APPLICATIONS

- Characterized for Use to 300 mA
- High-Voltage Outputs
- No Output Latch-Up at 55 V (After Conducting 300 mA)
- Medium-Speed Switching
- Circuit Flexibility for Varied Applications and Choice of Logic Function
- TTL-Compatible Diode-Clamped Inputs
- Standard Supply Voltages
- Plastic DIP (P) With Copper Lead Frame Provides Cooler Operation and Improved Reliability

D OR P PACKAGE (TOP VIEW)



SUMMARY OF SERIES SN75471

DEVICE	LOGIC OF COMPLETE CIRCUIT	PACKAGES
SN75471	AND	D, P
SN75472	NAND	D, P
SN75473	OR	D, P

description

Series SN75471 dual peripheral drivers are functionally interchangeable with series SN75451B and series SN75461 peripheral drivers, but are designed for use in systems that require higher breakdown voltages than either of those series can provide at the expense of slightly slower switching speeds than series 75451B (limits are the same as series SN75461). Typical applications include high-speed logic buffers, power drivers, relay drivers, lamp drivers, MOS drivers, line drivers, and memory drivers.

The SN75471, SN75472, and SN75473 are dual peripheral AND, NAND, and OR drivers, respectively, (assuming positive logic), with the output of the logic gates internally connected to the bases of the npn output transistors.

Series SN75471 drivers are characterized for operation from 0°C to 70°C.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage, V_I	5.5 V
Inter-emitter voltage (see Note 2)	5.5 V
Off-state output voltage, V_O	70 V
Continuous collector or output current (see Note 3)	400 mA
Peak collector or output current ($t_w \leq 10$ ms, duty cycle $\leq 50\%$, see Note 3)	500 mA
Continuous total power dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A	0°C to 70°C
Storage temperature range, T_{stg}	–65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

- NOTES: 1. Voltage values are with respect to the network GND, unless otherwise specified.
2. This is the voltage between two emitters, A and B.
3. Both halves of these dual circuits may conduct rated current simultaneously; however, power dissipation averaged over a short time interval must fall within the continuous dissipation rating.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING
D	725 mW	5.8 mW/°C	464 mW
P	1000 mW	8.0 mW/°C	640 mW

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V_{CC}	4.75	5	5.25	V
High-level input voltage, V_{IH}	2			V
Low-level input voltage, V_{IL}			0.8	V
Operating free-air temperature, T_A	0		70	°C



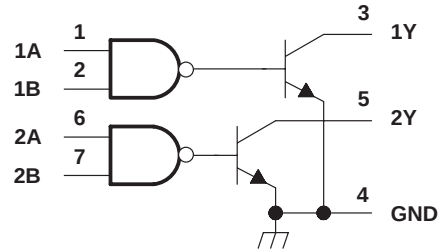
POST OFFICE BOX 655303 • DALLAS, TEXAS 75265

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)

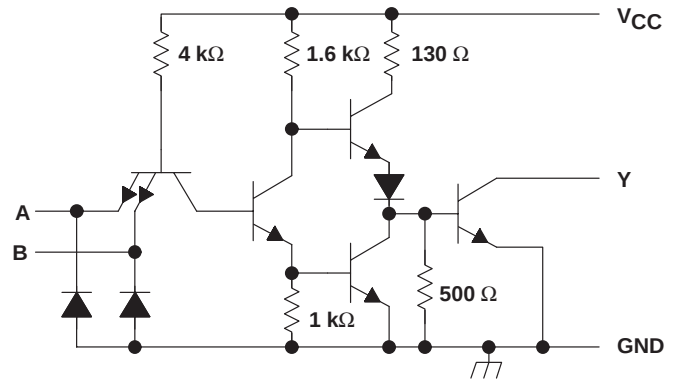


SN75471 FUNCTION TABLE
(each driver)

A	B	Y
L	L	L (on state)
L	H	L (on state)
H	L	L (on state)
H	H	H (off state)

positive logic:
 $Y = AB$ or $\bar{A} + \bar{B}$

SN75471 schematic (each driver)



Resistor values shown are nominal.

electrical characteristics over recommended operating free-air temperature range

PARAMETER	TEST CONDITIONS	SN75471			UNIT
		MIN	TYP‡	MAX	
V_{IK} Input clamp voltage	$V_{CC} = 4.75 \text{ V}$, $I_I = -12 \text{ mA}$	-1.2	-1.5		V
I_{OH} High-level output current	$V_{CC} = 4.75 \text{ V}$, $V_{IH} = 2 \text{ V}$, $V_{OH} = 70 \text{ V}$			100	μA
V_{OL} Low-level output voltage	$V_{CC} = 4.75 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OL} = 100 \text{ mA}$	0.25	0.4		V
	$V_{CC} = 4.75 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OL} = 300 \text{ mA}$	0.5	0.7		
I_I Input current at maximum input voltage	$V_{CC} = 5.25 \text{ V}$, $V_I = 5.5 \text{ V}$			1	mA
I_{IH} High-level input current	$V_{CC} = 5.25 \text{ V}$, $V_I = 2.4 \text{ V}$			40	μA
I_{IL} Low-level input current	$V_{CC} = 5.25 \text{ V}$, $V_I = 0.4 \text{ V}$	-1	-1.6		mA
I_{CCH} Supply current, outputs high	$V_{CC} = 5.25 \text{ V}$, $V_I = 5 \text{ V}$	7	11		mA
I_{CCL} Supply current, outputs low	$V_{CC} = 5.25 \text{ V}$, $V_I = 0$	52	65		mA

‡ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	SN75471			UNIT
		MIN	TYP	MAX	
t_{PLH} Propagation delay time, low-to-high-level output	$I_O \approx 200 \text{ mA}$, $C_L = 15 \text{ pF}$, $R_L = 50 \Omega$, See Figure 1		30	55	ns
t_{PHL} Propagation delay time, high-to-low-level output			25	40	
t_{TLH} Transition time, low-to-high-level output			8	20	
t_{THL} Transition time, high-to-low-level output			10	20	
V_{OH} High-level output voltage after switching	$V_S = 55 \text{ V}$, $I_O \approx 300 \text{ mA}$, See Figure 2	$V_S - 18$			mV

SN75471 THRU SN75473
DUAL PERIPHERAL DRIVERS

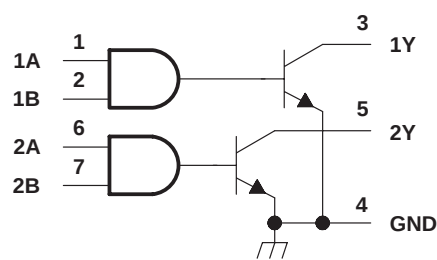
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logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)

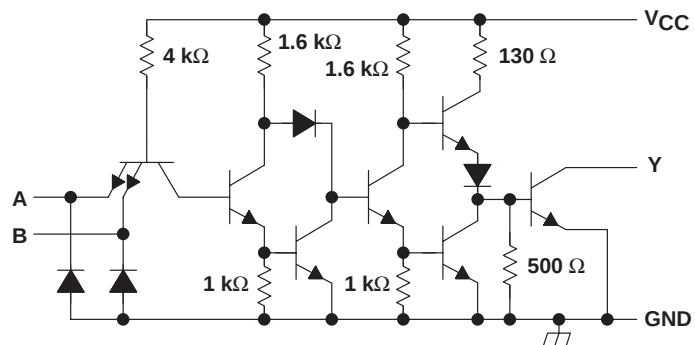


SN75472 FUNCTION TABLE
(each driver)

A	B	Y
L	L	H (off state)
L	H	H (off state)
H	L	H (off state)
H	H	L (on state)

positive logic:
 $Y = \overline{AB}$ or $\overline{A} + \overline{B}$

SN75472 schematic (each driver)



Resistor values shown are nominal.

electrical characteristics over recommended operating free-air temperature range

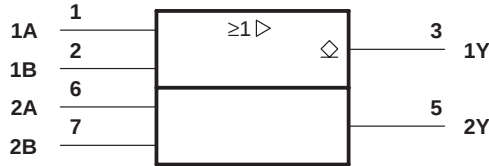
PARAMETER	TEST CONDITIONS	SN75472			UNIT
		MIN	TYP‡	MAX	
V _{IK} Input clamp voltage	V _{CC} = 4.75 V, I _I = -12 mA	-1.2	-1.5		V
I _{OH} High-level output current	V _{CC} = 4.75 V, V _{IH} = 2 V, V _{OH} = 70 V		100		μA
V _{OL} Low-level output voltage	V _{CC} = 4.75 V, V _{IL} = 0.8 V, I _{OL} = 100 mA	0.25	0.4		V
	V _{CC} = 4.75 V, V _{IL} = 0.8 V, I _{OL} = 300 mA	0.5	0.7		
I _I Input current at maximum input voltage	V _{CC} = 5.25 V, V _I = 5.5 V		1		mA
I _{IH} High-level input current	V _{CC} = 5.25 V, V _I = 2.4 V		40		μA
I _{IL} Low-level input current	V _{CC} = 5.25 V, V _I = 0.4 V	-1	-1.6		mA
I _{CCH} Supply current, outputs high	V _{CC} = 5.25 V, V _I = 5 V	13	17		mA
I _{CCL} Supply current, outputs low	V _{CC} = 5.25 V, V _I = 0	61	76		mA

‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

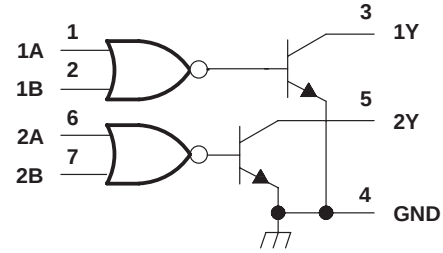
PARAMETER	TEST CONDITIONS	SN75472			UNIT
		MIN	TYP	MAX	
t _{PLH} Propagation delay time, low-to-high-level output	I _O ≈ 200 mA, C _L = 15 pF, R _L = 50 Ω, See Figure 1		45	65	ns
t _{PHL} Propagation delay time, high-to-low-level output			30	50	
t _{TLH} Transition time, low-to-high-level output			13	25	
t _{THL} Transition time, high-to-low-level output			10	20	
V _{OH} High-level output voltage after switching	V _S = 55 V, I _O ≈ 300 mA, See Figure 2	V _S - 18			mV

logic symbol†



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)

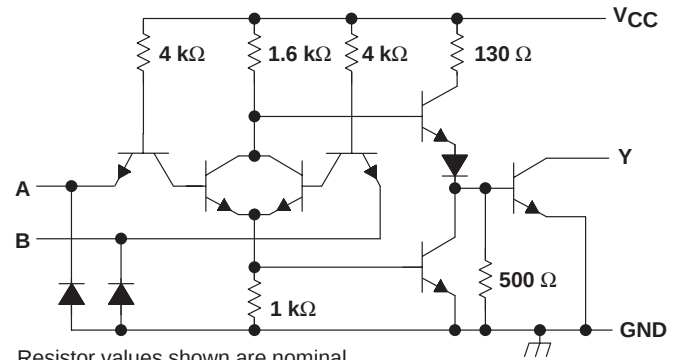


**FUNCTION TABLE
(each driver)**

A	B	Y
L	L	L (on state)
L	H	H (off state)
H	L	H (off state)
H	H	H (off state)

positive logic:
 $Y = A + B$ or $\overline{A} \overline{B}$

schematic (each driver)



Resistor values shown are nominal.

electrical characteristics over recommended operating free-air temperature range

PARAMETER	TEST CONDITIONS	SN75473			UNIT
		MIN	TYP‡	MAX	
V_{IK} Input clamp voltage	$V_{CC} = 4.75 \text{ V}$, $I_I = -12 \text{ mA}$	-1.2	-1.5		V
I_{OH} High-level output current	$V_{CC} = 4.75 \text{ V}$, $V_{IH} = 2 \text{ V}$, $V_{OH} = 70 \text{ V}$			100	μA
V_{OL} Low-level output voltage	$V_{CC} = 4.75 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OL} = 100 \text{ mA}$	0.25	0.4		V
	$V_{CC} = 4.75 \text{ V}$, $V_{IL} = 0.8 \text{ V}$, $I_{OL} = 300 \text{ mA}$	0.5	0.7		
I_I Input current at maximum input voltage	$V_{CC} = 5.25 \text{ V}$, $V_I = 5.5 \text{ V}$			1	mA
I_{IH} High-level input current	$V_{CC} = 5.25 \text{ V}$, $V_I = 2.4 \text{ V}$			40	μA
I_{IL} Low-level input current	$V_{CC} = 5.25 \text{ V}$, $V_I = 0.4 \text{ V}$	-1	-1.6		mA
I_{CCH} Supply current, outputs high	$V_{CC} = 5.25 \text{ V}$, $V_I = 5 \text{ V}$		8	11	mA
I_{CCL} Supply current, outputs low	$V_{CC} = 5.25 \text{ V}$, $V_I = 0$		58	76	mA

‡ All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

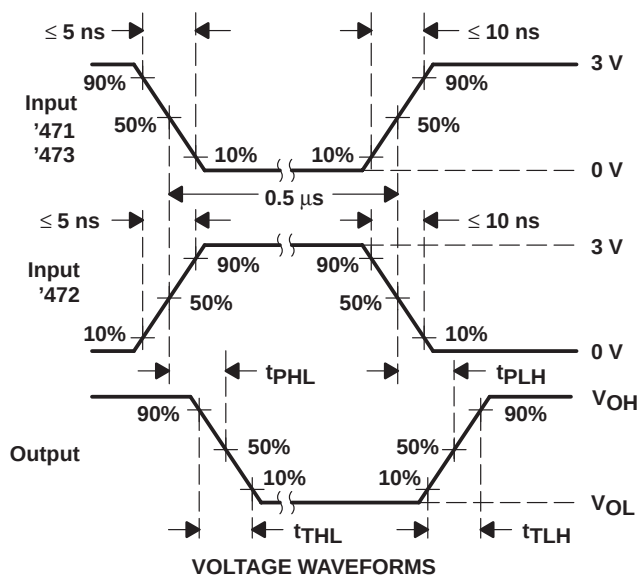
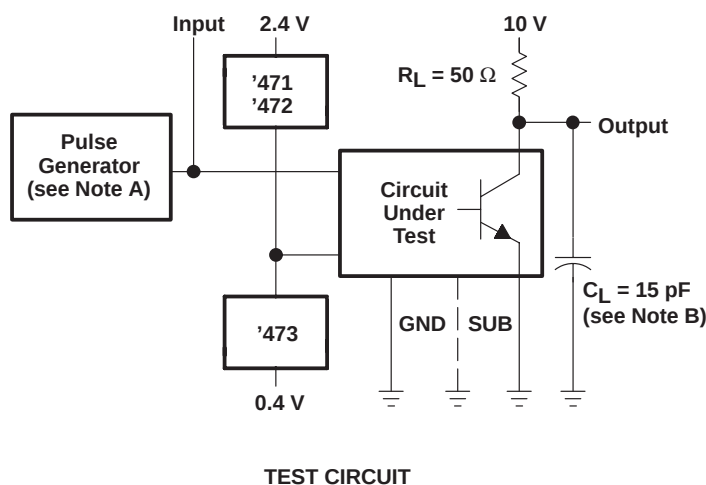
switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	SN75473			UNIT
		MIN	TYP	MAX	
t_{PLH} Propagation delay time, low-to-high-level output	$I_O \approx 200 \text{ mA}$, $C_L = 15 \text{ pF}$, $R_L = 50 \Omega$, See Figure 1		30	55	ns
t_{PHL} Propagation delay time, high-to-low-level output			25	40	
t_{TLH} Transition time, low-to-high-level output			8	25	
t_{THL} Transition time, high-to-low-level output			10	25	
V_{OH} High-level output voltage after switching	$V_S = 55 \text{ V}$, $I_O \approx 300 \text{ mA}$, See Figure 2	$V_S - 18$			mV

SN75471 THRU SN75473 DUAL PERIPHERAL DRIVERS

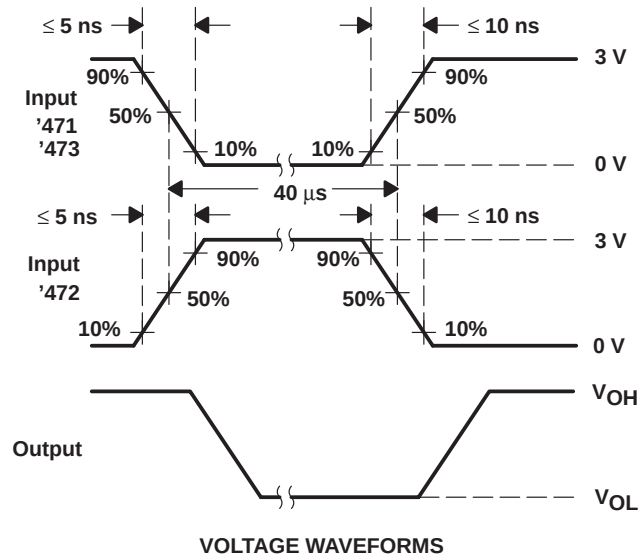
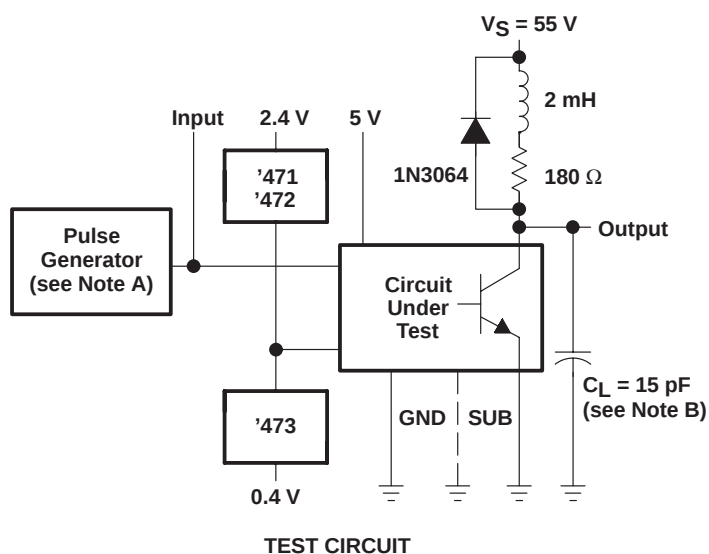
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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The pulse generator has the following characteristics: $PRR \leq 1 \text{ MHz}$, $Z_O \approx 50 \Omega$.
B. C_L includes probe and jig capacitance.

Figure 1. Switching Times



- NOTES: A. The pulse generator has the following characteristics: $PRR \leq 12.5 \text{ kHz}$, $Z_O \approx 50 \Omega$.
B. C_L includes probe and jig capacitance.

Figure 2. Latch-Up Test

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